## EE 508 Lecture 40

Noise and Dynamic Range Digital Filters

#### **Review from last lecture**

#### Noise sources in electronic circuits

Resistors, Transistors, and Diodes all have one or more internal noise sources



Capacitors and Inductors are noiseless

The presence of noise sources in devices is the only reason that input signals in filters are not made arbitrarily small to reduce effects of nonlinearity to arbitrarily small levels

The concept of "Dynamic Range" is used to characterize how small of input signals can be practically used in filters

To achieve acceptable linearity in a filter, the designer should provide just enough "dynamic range" to satisfy the requirements of an application. Any extra dynamic range will invariably come at the expense of increased design efforts, cost, complexity, and power dissipation



From Wikipedia:

"Dynamic range is the ratio of a specified maximum level of a parameter (e.g. quantity), such as power, current, voltage, or frequency, to the minimum detectable value of that parameter "

- The maximum level of such a quantity is strongly dependent upon the distortion acceptable in a particular application
- This value may be dependent upon frequency
- The minimum detectable value of a quantity may be dependent upon application Some authors interpret the minimum detectable value to be the RMS value of the quantity when the input signal is zero
- The use of a single value for the DR for a filter without knowing the specific applications is of questionable use



From Allen and Holberg:

"whereas noise imposes a lower limit on the range of signal amplitudes that can be meaningfully processed by a circuit, linearity often imposes the upper limit. The difference between them is the dynamic range"

From Gregorian and Temes: (in the context of op amp circuits)

"Due to the limited linear range of the op-amp, there is a maximum input signal amplitude,  $V_{in,max}$  which the device can handle without generating an excessive amount of nonlinear distortion. ..... Due to spurious signals (noise, clock feedthrough, low-level distortion such as crossover distortion, etc.) there is also a minimum input signal  $V_{in,min}$  which still does now drown in noise and distortion. The dynamic range of the op amp is then defined as  $20\log_{10} \left( \frac{V_{in,max}}{V_{in,min}} \right)$  measured in decibels."

Numerous definitions for DR include some "qualitative" terms in the definition making it difficult to identify a universally accepted definition of the DR though the concept is useful



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SNDR is a metric that is rigorously defined that captures some of the DR properties

Though the concept of DR is often not discussed rigorously and though there are various definitions of DR, Dynamic Range should be the primary driver of signal swing, power dissipation, and architecture selection not only in filter circuits but in analog circuit design in general



If  ${m v}_n(t_1)$  is a sample of  ${m v}_n(t)$ , then  ${m v}_n(t_1)$  is a random variable

For almost all noise sources, the distribution of  $\mathcal{V}_n(t_1)$  is zero mean and often Gaussian

For many noise sources, if  $v_n(t_1)$  and  $v_n(t_2)$  are two distinct samples with  $t_1 \neq t_2$ , these random variables are identically distributed and uncorrelated (iid)

Noise (voltage) is also characterized by how it is distributed throughout the frequency spectrum by its power spectral density, S, or voltage spectral density  $S_V$ 

Thus noise is characterized by both S and the amplitude distribution function and these are distinct characterizations

#### Statistical Characterization of Noise



The RMS noise voltage in the frequency band  $[f_1, f_2]$  is given by the expression

$$\mathcal{V}_{RMS}(f_1, f_2) = \sqrt{\begin{pmatrix} f_2 \\ f_1 \end{pmatrix}} \mathcal{S}df$$
 or  
$$S = S_V^2$$
  
$$S = S_V^2$$

 $S_v^2$ 

And the total RMS noise voltage is given by the expression

$$\mathcal{U}_{RMS} = \sqrt{\left(\int_{0}^{\infty} \mathcal{S} df\right)}$$

#### **Statistical Characterization of Noise**



#### Parseval's Theorem

$$\sqrt{\int_{f=0}^{\infty} \mathrm{Sdf}} = \lim_{T \to \infty} \int_{t_1}^{t_1+T} \mathcal{V}^2(t) dt$$



If the spectrum is flat, then the noise is termed "white" noise

White noise can have an amplitude distribution that is Gaussian or non-Gaussian

For a resistor, the noise spectrum is white (over a very wide frequency range), the amplitude distribution is Gaussian, and any two distinct samples are iid.



$$S = 4kTR$$
 ( $V^2$  / Hz or  $V^2$  sec)



Often for audio filters, the DR is defined to be the ratio at the output between that due to a signal at 1% THD to the RMS noise voltage with the actual output spectrum multiplied by that of a C-Message bandpass filter



Figure 5. Weighting filter responses, actual measurements. Note that ANSI and C weighting filters are undefined above 20 kHz.

From "Audio Measurement Handbook" by Bob Metzlar

## Analysis of Noise in Filter Circuits

Consider a filter circuit with N noise voltage sources (can be easily modified to include both noise voltage and current sources)



The noise sources can be represented by the block diagram shown below



Assume  $T_k(s)$  is the transfer function from the kth source to the output

By superposition

$$V_{OUT}(s) = \sum_{i=1}^{N} T_i(s) V_i(s)$$

#### Analysis of Noise in Filter Circuits



If the noise sources are uncorrelated with spectral density  $S_1$ , ...  $S_N$ , the spectral density and the RMS noise voltage at the output are given by the equations:

$$S_{OUT} = \sum_{i=1}^{N} S_i \bullet \left| T_i \left( j \omega \right) \right|^2$$

$$\mathcal{U}_{OUT\_RMS} = \sqrt{\int_{f=0}^{\infty} S_{OUT} df} = \sqrt{\int_{f=0}^{\infty} \sum_{i=1}^{N} S_i \bullet \left| T_i \left( j\omega \right) \right|^2 df}$$

### Analysis of Noise in Filter Circuits



A noise analysis in the frequency domain can be easily run in Spectre to obtain the RMS noise voltage at the output

This can be referred back to the input by dividing by the gain from the input to the output to determine the input-referred SNR (see next page)

There is now a time-domain noise analysis capability in Cadence so actual time-domain noise analysis is possible

 $oldsymbol{\mathcal{V}}_{ extsf{NO}}$  usually not part of the filter so affects system but not filter

#### Input-Referred Noise in Filter Circuits



$$\mathcal{U}_{OUT\_RMS} = \sqrt{\int_{f=0}^{\infty} S_{OUT} df} = \sqrt{\int_{f=0}^{\infty} \sum_{i=1}^{N} S_i \bullet \left| T_i \left( j \omega \right) \right|^2 df}$$

Let T(s) be the transfer function from the input to the output. (usually T(s) will be distinct from each of the noise transfer functions).

The input-referred noise spectral density is given by the expression

$$S_{IN} = \frac{S_{OUT}}{\left| T \left( j \omega \right)^2 \right|}$$

The input-referred RMS voltage is thus given by

$$\mathcal{U}_{IN\_RMS} = \sqrt{\int_{f=0}^{\infty} \frac{S_{OUT}}{\left|T\left(j\omega\right)\right|^{2}} df} = \sqrt{\int_{f=0}^{\infty} \sum_{i=1}^{N} S_{i} \cdot \left|\frac{T_{i}\left(j\omega\right)\right|^{2}}{\left|T\left(j\omega\right)\right|^{2}} df$$

# Relationship between frequency domain and time domain noise analysis



$$\mathcal{V}_{OUT\_RMS} = \sqrt{\int_{f=0}^{\infty} S_{OUT} df} = \sqrt{\int_{f=0}^{\infty} \sum_{i=1}^{N} S_i \bullet \left| T_i \left( j \omega \right) \right|^2 df}$$

$$V_{\text{RMS_OUT}} = E\left(\sqrt{\lim_{T \to \infty} \left(\frac{1}{T}\int_{0}^{T} V_{OUT}^{2}(t)dt\right)}\right) \simeq \sqrt{\lim_{T \to \infty} \left(\frac{1}{T}\int_{0}^{T} V_{OUT}^{2}(t)dt\right)}$$

Parseval's Theorem

$$\mathsf{V}_{_{\mathsf{RMS}}\mathsf{out}} = \mathcal{V}_{_{OUT}\mathit{_{RMS}}}$$

Example: First-Order RC Network



Example: First-Order RC Network



From a standard change of variable with a trig identity, it follows that

$$\mathcal{V}_{n_{RMS}} = \sqrt{\int_{f=0}^{\infty} S_{V_{OUT}} df} = \sqrt{\frac{kT}{C}}$$

- Note the continuous-time noise voltage has an RMS value that is independent of R
- The noise contributed by the resistor is dependent only upon the capacitor value C
- This is often referred to at kT/C noise and it can be decreased at a given T only by increasing C

#### Example: First-Order RC Network



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#### Noise Associated with Capacitors

"kT/C" Noise at T=300K













 $artheta_{
m n}$ (kT) is a discrete-time sequence obtained by sampling a continuous-time noise waveform

Characterization of a noise sequence



**Theorem** If v(t) is a continuous-time zero-mean noise source and  $\langle v(kT) \rangle$  is a sampled version of v(t) sampled at times T, 2T, .... then the RMS value of the continuous-time waveform is the same as that of the sampled version of the waveform. This can be expressed as  $v_{\rm RMS} = \hat{v}_{\rm RMS}$ 

**Theorem** If v(t) is a continuous-time zero-mean noise signal and  $\langle v(kT) \rangle$  is a sampled version of v(t) sampled at times T, 2T, .... then the standard deviation of the random variable v(kT), denoted as  $\sigma_v$ 

satisfies the expression 
$$\sigma_{\rm v}$$
 =  $\vartheta_{\rm RMS}$  =  $\vartheta_{\rm RMS}$ 



kT C  $\mathcal{V}_{n_{RMS}}$ 

What is the RMS value of the output noise voltage due to the noise on  $R_s$ ?



What is the RMS value of the output noise voltage due to the noise on  $R_L$  and  $R_S$ ?



# **Digital Filters**

#### **Limitations of Analog Filters**

- Transfer functions sensitive to component and process variations
- Distortion inherent due to nonlinearities in components (particularly amplifiers)
- Power dissipation can be large
- Area gets large, often unacceptably so for very low frequency poles and even of concern for audio-frequency poles
- Programmability introduces considerable complexity (with existing approaches)
- Making minor changes in filter requirements often necessitates a major redesign effort

#### **Advantages of Analog Filters**

Significant advantages but since comparative, will discuss later

#### Analog vs Digital Filter



### Analog vs Digital Filter



- Imaginary axis for analog filters corresponds to unit circle for digital filters
- Several standard mappings used to map between s-domain and z-domain
- Some actually map imaginary axis to unit circle



#### **Filter Design Processes**



#### **Analolg Filter**

### **Digital Filter Properties**



for 
$$\beta_0 = 1$$
 and  $a_i = \alpha_i$   
 $b_i = \beta_i$   $y(nT) = \sum_{i=0}^m a_i x(nT - iT) + \sum_{i=1}^n b_i y(nT - iT)$ 

If n=0 termed a Moving Average (MA) - only zeros present

If m=0 termed an Auto Regressive (AR) - only poles present If mn  $\neq 0$  termed Autoregressive Moving Average (ARMA) – poles and zeros present

## **Digital Filter Properties**



MA filters have a finite impulse response so are often termed FIR filters

If m=0 or mn  $\neq 0$  the filter will have one or more poles (and possibly many zeros but not necessarily any)

AR and ARMA filters have infinite impulse response so are often termed IIR filters

## **Digital Filter Properties**

#### **Moving Average Filters**



Impulse Response





# Stay Safe and Stay Healthy !

# End of Lecture 40